

HAOPIN MICROELECTRONICS CO., LTD.

Description

Passivated high commutation triacs in a plastic envelope intended for use in circuits where high static and dynamic dV/dt and high di/dt can occur. These devices will commutate the full rated ms current at the maximum rated junction temperature without the aid of a snubber.

Symbol		Simplified outline
		 TO-220
Pin	Description	
1	Main terminal 1 (T1)	
2	Main terminal 2 (T2)	
3	gate (G)	
TAB	Main terminal 2 (T2)	

Applications:

- ◆ Motor control
- Industrial and domestic lighting
- Heating
- Static switching

Features

- ◆ Blocking voltage to 600-1000 V
- On-state RMS current to 12 A

SYMBOL	PARAMETER	Value	Unit
V_{DRM}	Repetitive peak off-state voltages HP12Q60RC HP12Q80RC HP12QK0RC	600 800 1000	V
I_T (RMS)	RMS on-state current (full sine wave)	12	A
I_{TSM}	Non-repetitive peak on-state current (full cycle, T_j initial=25°C)	126	A

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
$R_{th(j-c)}$	Junction to case(AC)		—	1.4	—	°C/W
$R_{th(j-a)}$	Junction to ambient		—	60	—	°C/W



HP12Q series RC

Three quadrant triacs

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Limiting values in accordance with the Maximum system(IEC 134)

SYMBOL	PARAMETER	CONDITIONS			MIN	Value	UNIT
V_{DSM}/V_{RSM}	Non repetitive surge peak off-state voltage	tp=10ms			Tj=25°C	-	$V_{DRM}/V_{RRM} +100$
$I_{T(RMS)}$	RMS on-state current	full sine wave; Tc=105°C			-	12	A
I_{TSM}	Non repetitive surge peak on-state current	full cycle, Tj initial= 25 °C	F=50Hz	t=20ms	-	120	A
			F=60Hz	t=16.7ms	-	126	A
I^2t	I^2t Value for fusing	tp=10ms			-	78	A²s
dI/dt	Critical rate of rise of on-state current	$I_G=2x I_{GT}, tr \leq 100ns$	F=120Hz	Tj=125°C	-	50	A/μs
I_{GM}	Peak gate current	tp=20us	Tj=125°C	-	4	A	
I_{DRM}	$V_{DRM}=V_{RRM}$		Tj=25°C	-	5	μA	
I_{RRM}	$V_{DRM}=V_{RRM}$		Tj=125°C	-	1	mA	
$P_{G(AV)}$	Average gate power dissipation			Tj=125°C	-	1	W
T_{stg}	Storage junction temperature range			-40	150	°C	
T_j	Operating junction Temperature range			-40	125	°C	

T_j=25°C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Static characteristics						
$I_{GT}(1)$ V_{GT}		$V_D=12V; R_L=30\Omega$ I-II-III I-II-III	-	-	35 1.3	mA V
I_L		$I_G=1.2 I_{GT}$ I-III II	-	-	50 60	mA
$I_H(2)$		$I_T=100mA$	-	-	35	mA
V_{GD}		$V_D=V_{DRM} R_L=3.3K\Omega Tj=125°C$ I-II-III	0.2	-	-	V
$dV/dt(2)$		$V_D=67\% V_{DRM}$ gate open; Tj=125°C	500	-	-	V/μs
(dI/dt)c(2)		without snubber Tj=125°C	6.5	-	-	A/ms

Dynamic Characteristics

$V_T(2)$	$I_{TM}=17A$ tp=380 μs	Tj=25°C	-	-	1.55	V
$V_{to}(2)$ $R_d(2)$	Threshold voltage Dynamic resistance	Tj=125°C Tj=125°C	-	-	0.85 35	V mΩ

Note 1: minimum I_{GT} is guaranteed at 5% of I_{GT} max.

Note 2: for both polarities of A2 referenced to A1.

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Description

Fig. 1: Maximum power dissipation versus RMS on-state current (full cycle).

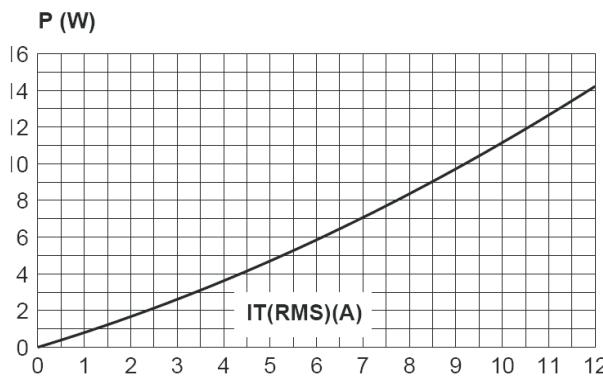


Fig. 2-1: RMS on-state current versus case temperature (full cycle).

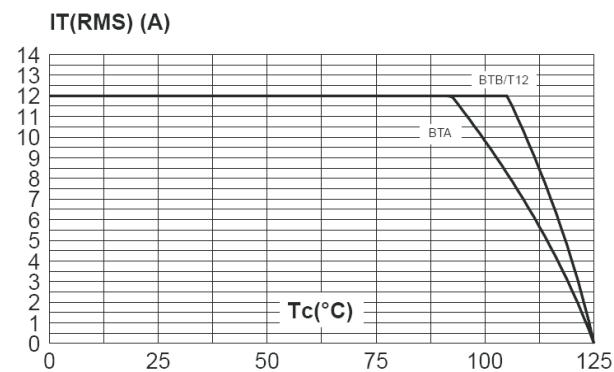


Fig. 2-2: RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35μm), full cycle.

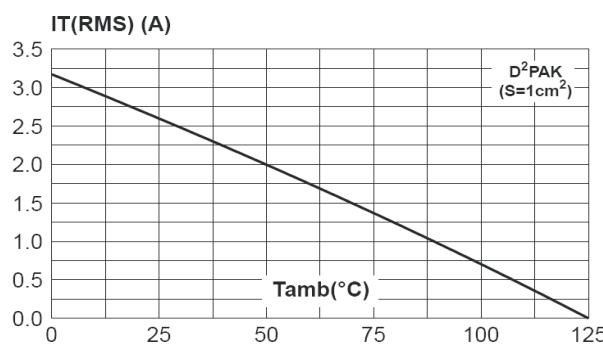


Fig. 3: Relative variation of thermal impedance versus pulse duration.

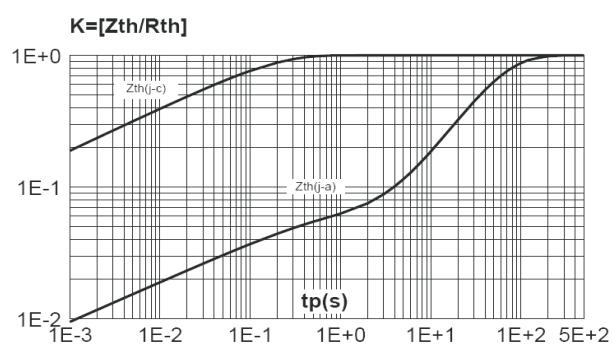


Fig. 4: On-state characteristics (maximum values).

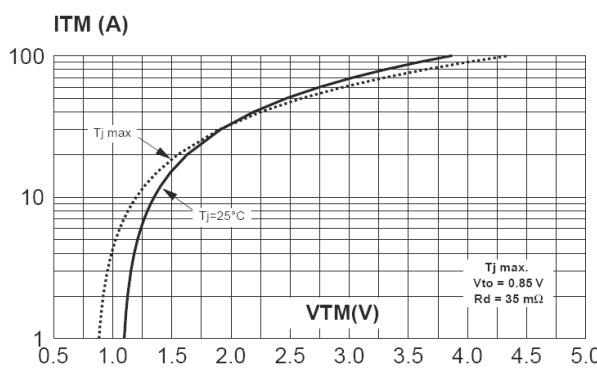
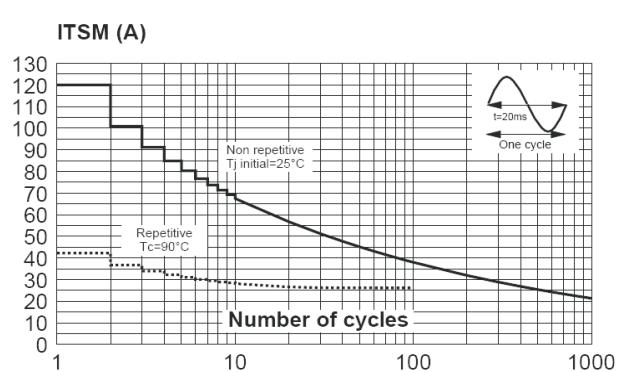


Fig. 5: Surge peak on-state current versus number of cycles.



Description

Fig. 6: Non-repetitive surge peak on-state current for a sinusoidal pulse with width $t_p < 10\text{ms}$, and corresponding value of I^2t .

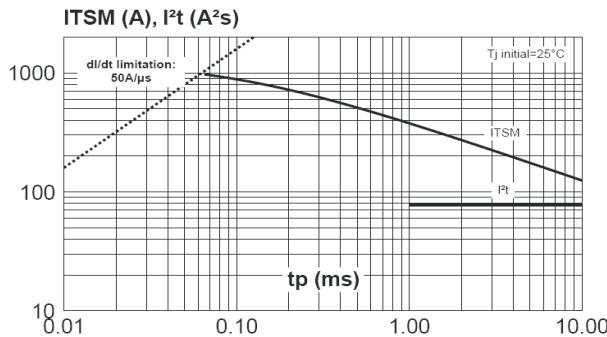


Fig. 7: Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).

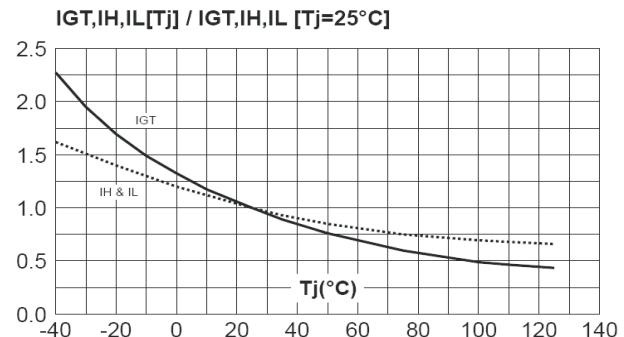


Fig. 8-1: Relative variation of critical rate of decrease of main current versus $(dV/dt)_c$ (typical values) (BW/CW/T1235).

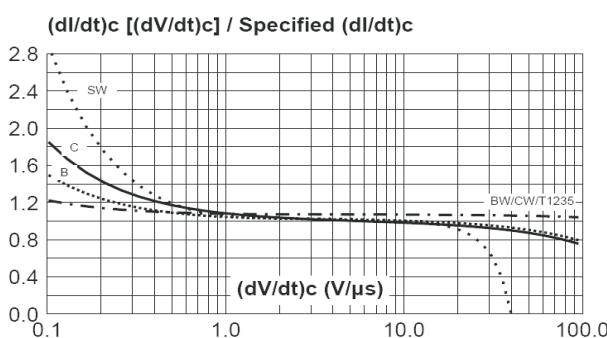


Fig. 8-2: Relative variation of critical rate of decrease of main current versus $(dV/dt)_c$ (typical values) (TW).

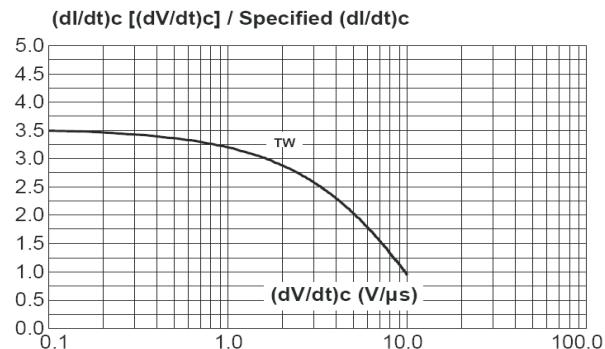


Fig. 9: Relative variation of critical rate of decrease of main current versus junction temperature.

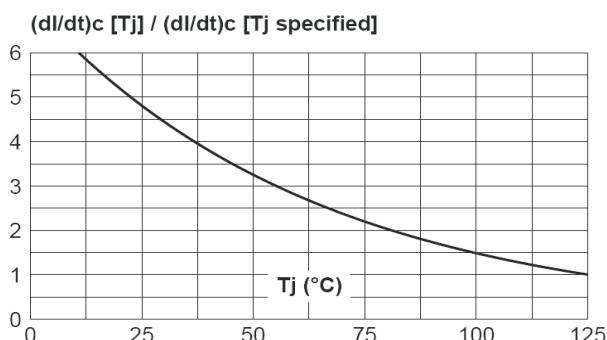
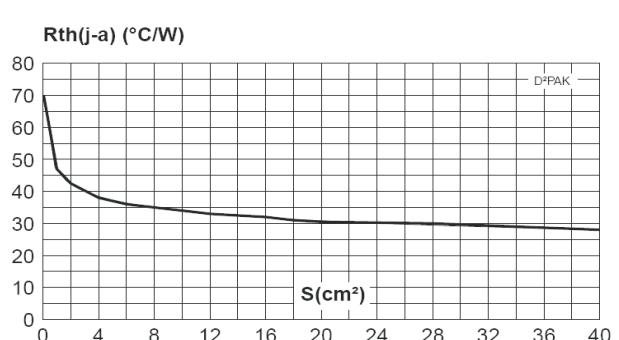


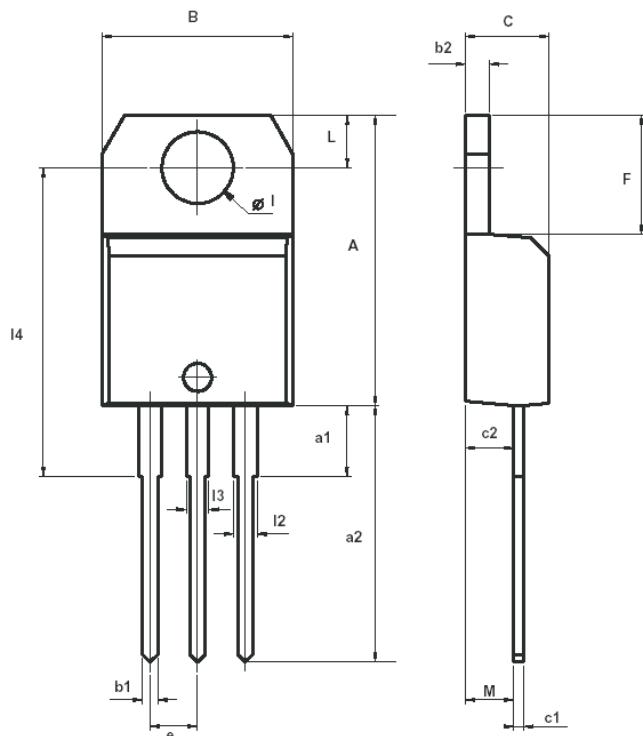
Fig. 10: D²PAK Thermal resistance junction to ambient versus copper surface under tab (printed circuit board FR4, copper thickness: 35 μm).



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MECHANICAL DATA

Dimensions in mm
Net Mass: 2 g



REF.	DIMENSIONS					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	15.20		15.90	0.598		0.625
a1		3.75			0.147	
a2	13.00		14.00	0.511		0.551
B	10.00		10.40	0.393		0.409
b1	0.61		0.88	0.024		0.034
b2	1.23		1.32	0.048		0.051
C	4.40		4.60	0.173		0.181
c1	0.49		0.70	0.019		0.027
c2	2.40		2.72	0.094		0.107
e	2.40		2.70	0.094		0.106
F	6.20		6.60	0.244		0.259
I	3.75		3.85	0.147		0.151
l4	15.80	16.40	16.80	0.622	0.646	0.661
L	2.65		2.95	0.104		0.116
l2	1.14		1.70	0.044		0.066
l3	1.14		1.70	0.044		0.066
M		2.60			0.102	